

# **LCP1511D**

# Application Specific Discretes A.S.D.™

# PROGRAMMABLE TRANSIENT VOLTAGE SUPPRESSOR FOR SLIC PROTECTION

#### **FEATURES**

- DUAL PROGRAMMABLE TRANSIENT SUP-PRESSOR.
- WIDE NEGATIVE FIRING VOLTAGE RANGE : V<sub>MGL</sub> = -80V max.
- LOW DYNAMIC SWITCHING VOLTAGES: V<sub>FP</sub> and V<sub>DGL</sub>.
- LOW GATE TRIGGERING CURRENT :  $I_{GT} = 5mA max$ .
- PEAK PULSE CURRENT: I<sub>PP</sub> = 30A for 10/1000µs surge.
- HOLDING CURRENT: I<sub>H</sub> = 150mA.

#### **DESCRIPTION**

This device has been especially designed to protect subscriber line card interfaces (SLIC) against transient overvoltages.

Positive overloads are clipped with 2 diodes. Negative surges are suppressed by 2 thyristors, their breakdown voltage being referenced to

-V<sub>BAT</sub> through the gate.

This component presents a very low gate trigge-ring current (I<sub>GT</sub>) in order to reduce the current consumption on printed circuit board during the firing phase.

A particular attention has been given to the internal wire bonding. The "4-point" configuration ensures reliable protection, eliminating the overvoltage introduced by the parasitic inductances of the wiring (Ldi/dt), especially for very fast transients.

#### **COMPLIES WITH THE FOLLOWING STANDARDS**

**CCITT K20**: 10/700μs 1kV

5/310μs 25A **VDE 0433**: 10/700μs 2kV

10/700μs 2kV 5/310μs 38A (\*)

**VDE 0878 :** 1.2/50μs 1.5kV

1/20µs 40A

**13124 :** 0.5/700μs 1kV 0.2/310μs 25A

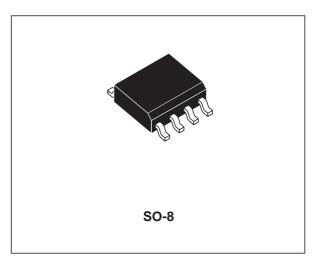
**FCC part 68**: 2/10μs 2.5kV

2/10µs 170A (\*)

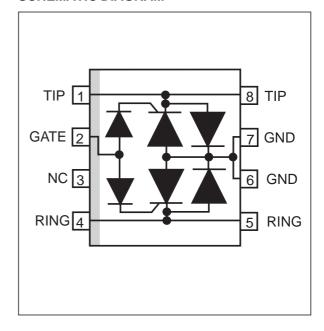
**BELLCORE** 

**TR-NWT-001089**: 2/10μs 2.5kV 2/10μs 170A (\*)

(\*) with series resistors or PTC.



#### **SCHEMATIC DIAGRAM**



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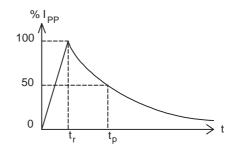
# LCP1511D

# ABSOLUTE MAXIMUM RATINGS $(T_{amb} = 25 \text{ °C})$

Symbol	Parameter	Value	Unit	
Ірр	Peak pulse current (see note 1)	30 38 170	А	
I <sub>TSM</sub>	Non repetitive surge peak on-state current (F = 50Hz)	8 3.5	А	
I <sub>GSM</sub>	Maximum gate current (half sine wave tp = 10ms	2	А	
V <sub>MLG</sub> V <sub>MGL</sub>	Maximum voltage LINE / GROUND Maximum voltage GATE / LINE	-100 -80	V	
T <sub>stg</sub> T <sub>j</sub>	Storage temperature range Maximum junction temperature	- 55 to + 150 150	°C	
TL	Maximum lead temperature for soldering during 1	0s	260	°C

### Note 1 : Pulse waveform :

10/1000μs	t <sub>r</sub> =10μs	tp=1000μs
5/310μs	t <sub>r</sub> =5μs	tp=310μs
2/10μs	t <sub>r</sub> =2μs	tp=10μs

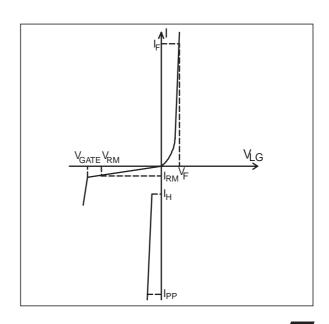


# THERMAL RESISTANCE

Symbol	Parameter	Value	Unit
R <sub>th (j-a)</sub>	Junction to ambient	170	°C/W

# **ELECTRICAL CHARACTERISTICS** (T<sub>amb</sub> = 25°C)

Symbol	Parameter
I <sub>GT</sub>	Gate triggering current
lΗ	Holding current
I <sub>RM</sub>	Reverse leakage current LINE/GND
I <sub>RG</sub>	Reverse leakage current GATE/LINE
V <sub>RM</sub>	Reverse voltage LINE/GND
V <sub>F</sub>	Forward drop voltage LINE/GND
V <sub>GT</sub>	Gate triggering voltage
V <sub>FP</sub>	Peak forward voltage LINE/GND
V <sub>DGL</sub>	Dynamic switching voltage GATE/LINE
V <sub>GATE</sub>	GATE/GND voltage
V <sub>LG</sub>	LINE/GND voltage
С	Off-state capacitance LINE/GND



# 1 - PARAMETERS RELATED TO THE DIODE LINE/GND ( $T_{amb} = 25$ °C)

Symbol	Test conditions				Maximum	Unit
V <sub>F</sub>	I <sub>F</sub> =5A	t <sub>p</sub> =500μs			3	V
V <sub>FP</sub>	10/700μs 1.2/50μs 2/10μs	1.5kV 1.5kV 2.5kV	$\begin{array}{l} R_p = 10\Omega \\ R_p = 10\Omega \\ R_p = 62\Omega \end{array}$	(see note 1)	5 7 12	V

**Note 1 :** See test circuit 2 for  $V_{FP}$ ;  $R_p$  is the protection resistor located on the line card.

# 2 - PARAMETERS RELATED TO THE PROTECTION THYRISTOR (T<sub>amb</sub> = 25°C)

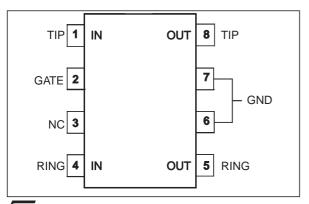
Sym- bol	Test conditions	Min.	Max.	Unit
I <sub>GT</sub>	V <sub>GND/LINE</sub> = -48V	0.2	5	mA
lΗ	V <sub>GATE</sub> =-48V (see note 2)	150		mA
V <sub>GT</sub>	at I <sub>GT</sub>		2.5	V
I <sub>RG</sub>	$T_c$ =25°C $V_{RG}$ =-75V $T_c$ =70°C $V_{RG}$ =-75V		5 50	μА
V <sub>DGL</sub>	VGATE= -48V (see note 3) 10/700μs 1.5kV Rp=10Ω I <sub>PP</sub> =30A 1.2/50μs 1.5kV Rp=10Ω I <sub>PP</sub> =30A 2/10μs 2.5kV Rp=62Ω I <sub>PP</sub> =38A		10 20 25	V

Note 2: See the functional holding current  $(I_H)$  test circuit 2.

# 3 - PARAMETERS RELATED TO DIODE AND PROTECTION THYRISTOR (Tamb = 25 °C)

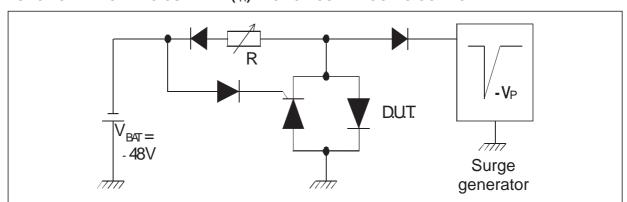
Sym- bol	Test condi	Maximum	Unit	
I <sub>RM</sub>	$T_c$ =25°C $V_{GATE/LINE}$ = -1V $T_c$ =70°C $V_{GATE/LINE}$ = -1V	V <sub>RM</sub> =-75V V <sub>RM</sub> =-75V	5 50	μΑ

### **APPLICATION NOTE**



In order to take advantage of the "4 point" structure of the LCP, the TIP and RING lines go across the device. In such case, the device will eliminate the overvoltages generated by the parasitic inductances of the wiring (Ldi/dt), especially for very fast transients.

# FUNCTIONAL HOLDING CURRENT (IH) TEST CIRCUIT 1 : GO-NO GO TEST

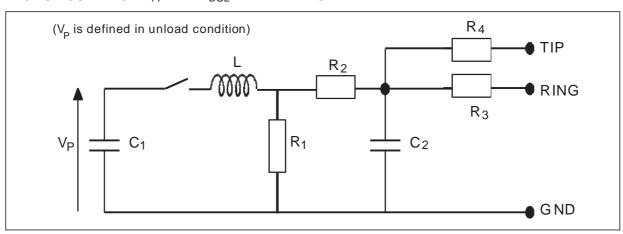


This is a GO-NO GO test which allows to confirm the holding current (I<sub>H</sub>) level in a functional test circuit.

### **TEST PROCEDURE:**

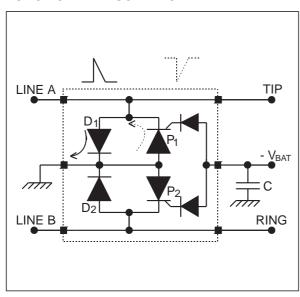
- Adjust the current level at the  $I_H$  value by short circuiting the D.U.T. Fire the D.U.T. with a surge current :  $I_{PP}$  = 10A, 10/1000 $\mu s$ .
- The D.U.T. will come back to the off-state within a duration of 50ms max.

## TEST CIRCUIT 2 FOR V<sub>FP</sub> AND V<sub>DGL</sub> PARAMETERS



Pulse	<b>e (μs)</b>	<b>V</b> p	<b>C</b> <sub>1</sub>	$\mathbf{C}_2$	L	$\mathbf{R}_1$	$R_2$	<b>R</b> <sub>3</sub>	$R_4$	<b>I</b> PP	Rp
t <sub>r</sub>	<b>t</b> p	(V)	<b>(μF)</b>	(nF)	<b>(μH)</b>	$(\Omega)$	<b>(</b> Ω <b>)</b>	<b>(</b> Ω <b>)</b>	<b>(</b> Ω <b>)</b>	(A)	<b>(</b> Ω <b>)</b>
10	700	1500	20	200	0	50	15	25	25	30	10
1.2	50	1500	1	33	0	76	13	25	25	30	10
2	10	2500	10	0	1.1	1.3	0	3	3	38	62

### **FUNCTIONAL DESCRIPTION**



### **LINE A PROTECTION:**

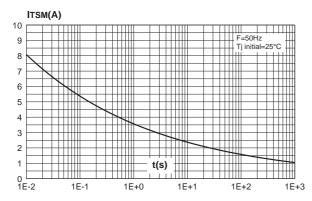
- For positive surges versus GND, the diode D1 will conduct.
- For negative surges versus GND, the protection device P1 will trigger at a voltage fixed by the -V<sub>BAT</sub> reference.

### **LINE B PROTECTION:**

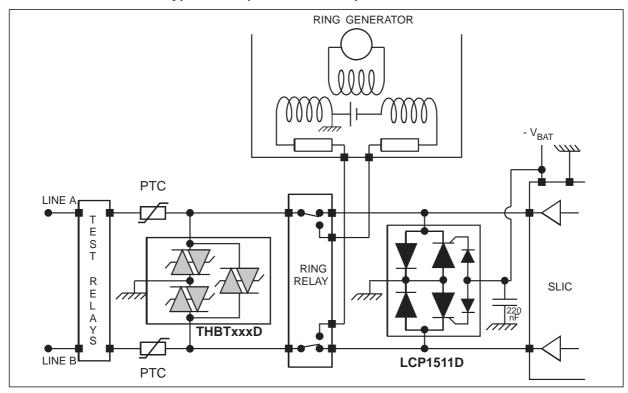
 For surges on line B, the operating mode is the same, D2 or P2 is activated.

It is recommended to add a capacitor (C=220nF) close to the gate of the LCP, in order to speed up the triggering.

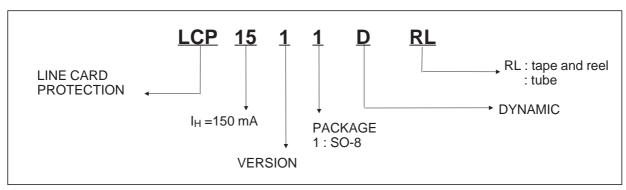
Surge peak current versus overload duration.



# **APPLICATION CIRCUIT: typical SLIC protection concept**



## **ORDER CODE**

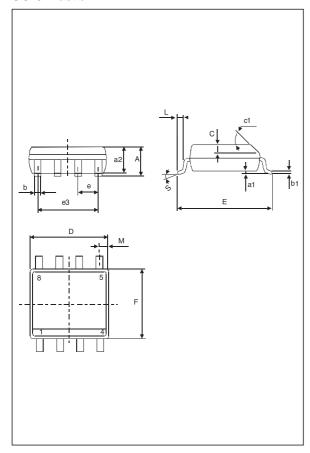


## **MARKING**

Package	Туре	Marking
SO-8	LCP1511D	CP151D

#### **PACKAGE MECHANICAL DATA**

SO-8 Plastic



	DIMENSIONS						
REF.	Mi	Millimetres			Inches		
	Min.	Тур.	Max.	Min.	Тур.	Max.	
Α			1.75			0.069	
a1	0.1		0.25	0.004		0.010	
a2			1.65			0.065	
b	0.35		0.48	0.014		0.019	
b1	0.19		0.25	0.007		0.010	
С		0.50			0.020		
c1			45°	(typ)			
D	4.8		5.0	0.189		0.197	
Е	5.8		6.2	0.228		0.244	
е		1.27			0.050		
e3		3.81			0.150		
F	3.8		4.0	0.15		0.157	
L	0.4		1.27	0.016		0.050	
М			0.6			0.024	
S	8° (max)						

**Weight =** 0.08 g.

**Packaging:** Product supplied in antistatic tubes or tape and reel.

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